Institut Matériaux Microélectronique Nanosciences Provence

Spectroscopie de réflectivité différentielle sur des couches moléculaires: aspects expérimentaux

Laurent Nony

laurent.nony@im2np.fr

Aix-Marseille Université, CNRS, IM2NP UMR 7334, 13397, Marseille, France

Ecole thématique « Couplage entre les techniques de microscopies à sondes locales et l'optique »
18-19 Mars 2019, Carry le Rouet

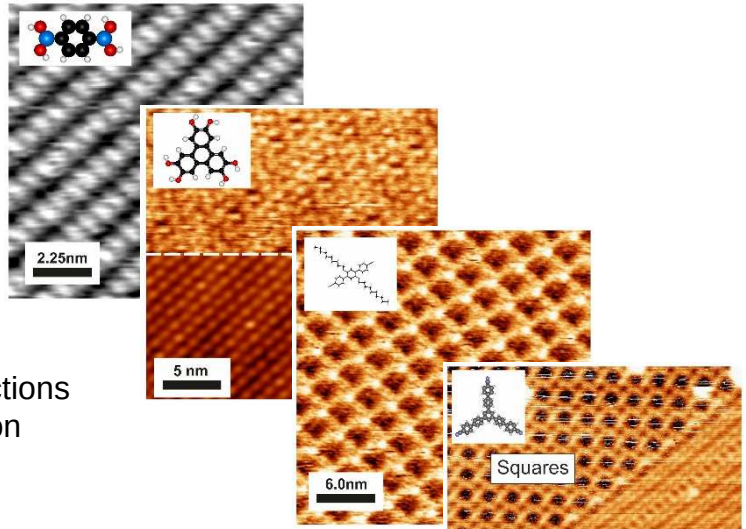
Research topics of the Nanostructuration group

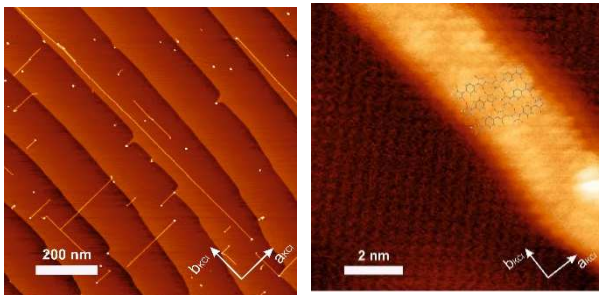
Molecular thin films on bulk dielectrics (weak charge transfer = intrinsic properties preserved)

- Supramolecular assemblies
- On-surface polymerization

STRUCTURE
- Peripheral groups
- Symetry / Epitaxy
- Comparative studies

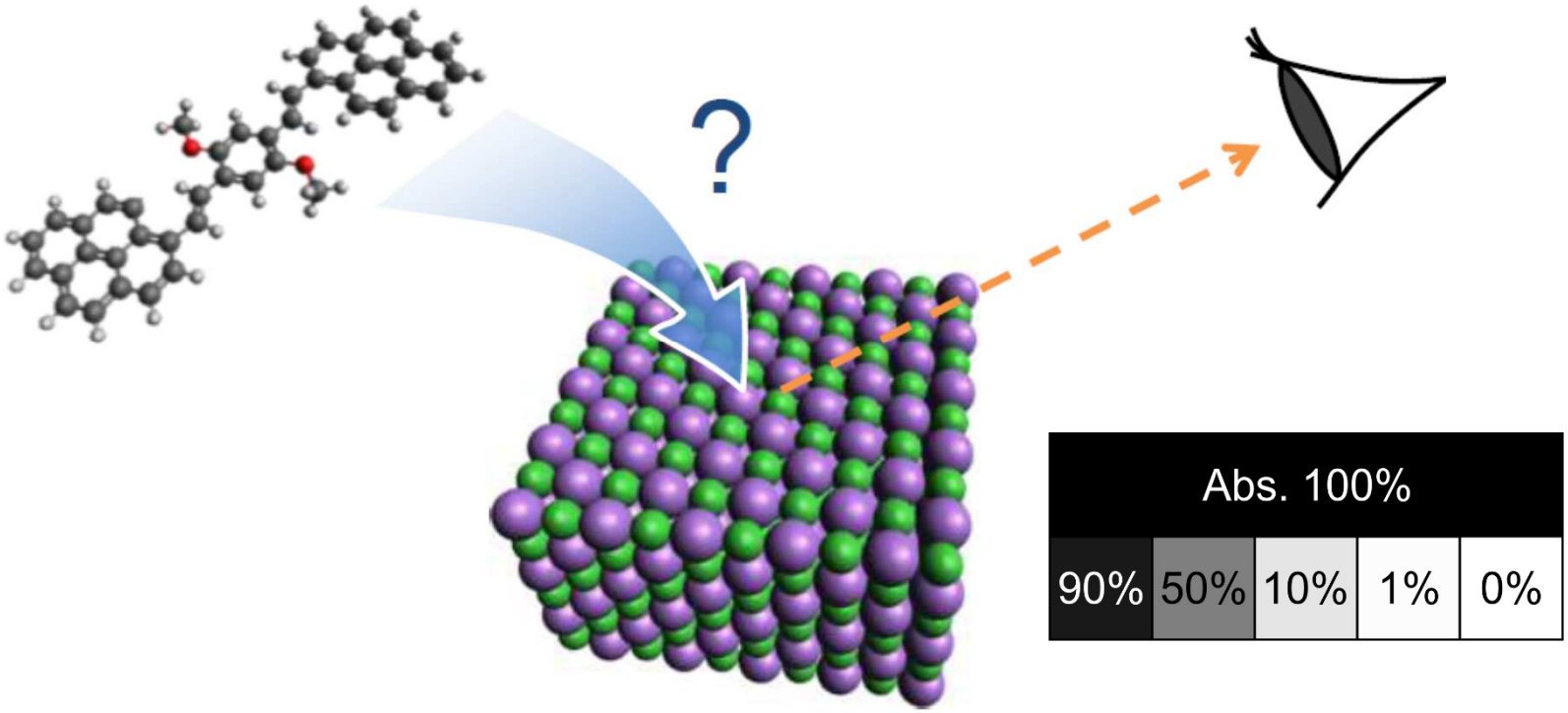
GROWTH
- MM vs. MS interactions
- Entropy contribution





Towards optical properties

Motivation: completing structural measurements with **optical spectroscopy**
structure ↔ property



Differential Reflectance Spectroscopy (DRS):

- ***in situ*** (UHV) & **real time UV-vis absorption spectra**
- sensitivity ~ 0.1% (~ sub-ML)

Outline

I. Reminder, context of DRS on molecular films

II. Tutorial video: experimental aspects of DRS on molecular films

III. Connection to the structural properties of the molecular films by nc-AFM

IV. DRS functionnal for fitting the DR spectra

V. Conclusion

List of publications

Outline

I. Reminder, context of DRS on molecular films

II. Tutorial video: experimental aspects of DRS on molecular films

III. Connection to the structural properties of the molecular films by nc-AFM

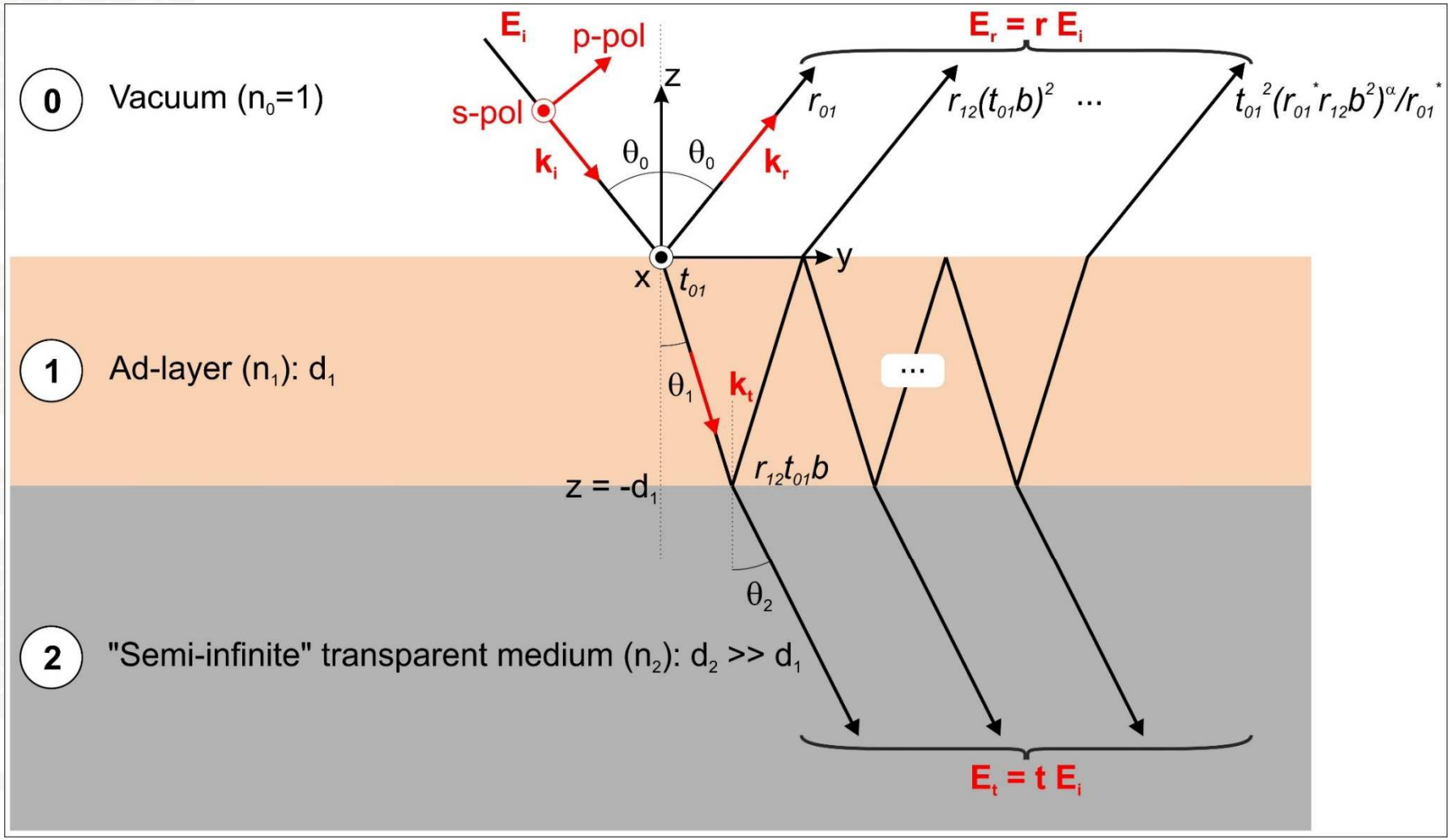
IV. DRS functionnal for fitting the DR spectra

V. Conclusion

List of publications

Reminder, context of DRS

- Differential Reflectance Spectroscopy:



Reminder, context of DRS

- Differential Reflectance Spectroscopy:
  - The combination between both Snell law, Fresnel equations and a linearization procedure[1] ($d_1 << l$) yields to the so-called ***Mc Intyre's approach*** to DRS:

$$\mathrm{DRS}^{(s)} = \frac{R(d_1) - R(0)}{R(0)} = \frac{|\,\tilde{r}(d_1)\,|^2 - |\,\tilde{r}(0)\,|^2}{|\,\tilde{r}(0)\,|^2} = \frac{8\pi d_1 \cos\theta_0}{\lambda(n_2^2 - 1)}\mathrm{Im}\{\tilde{n}_1^2\}$$

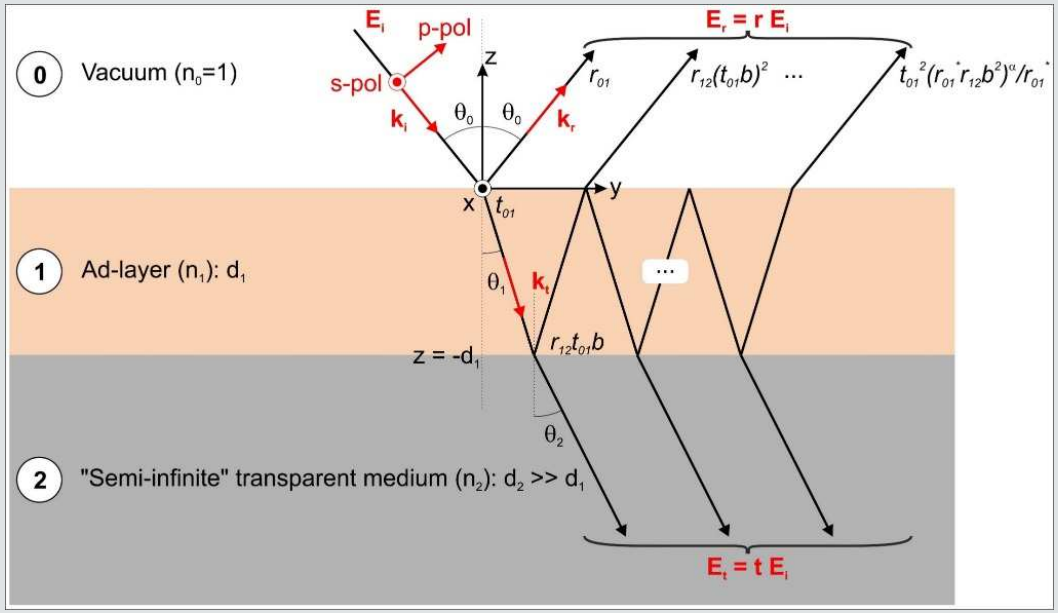
  - Relates to the **optical absorption of the molecular film**
  - **Goal: quantitative determination of the molecular film's dielectric function ε(λ)** (or its refractive index: $n(\lambda) = \sqrt{\varepsilon(\lambda)}$)

[1] J.D.E.McIntyre et al., Surf.Sci. 24, 417 (1971)

Reminder, context of DRS

- Franck Bocquet's lecture on « Theoretical aspects of DRS on molecular films »:

Dans le principe: c'est « simple », car on analyse un multicouche optique!



Equations de passage aux interfaces ➔ Relations de Fresnel ➔ Intensité spéculaire:

- Plusieurs interfaces: *approche matricielle des milieux stratifiés*
- Couches anisotropes: *approche tensorielle, complexe voire très complexe!*
- Rugosités interfaciales : complexe mais faisable *(modèle Gaussien, milieu effectif…)*

NECESSITE D'INJECTER L'INDICE n(λ) DU FILM : MAIS en général n(λ) est INCONNU

Reminder, context of DRS

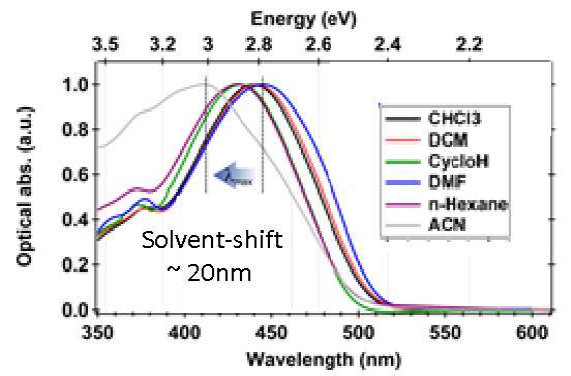
- Franck Bocquet's lecture on « Theoretical aspects of DRS on molecular films »:

Calcul de la DRS **et** fit de n(λ) simultanément

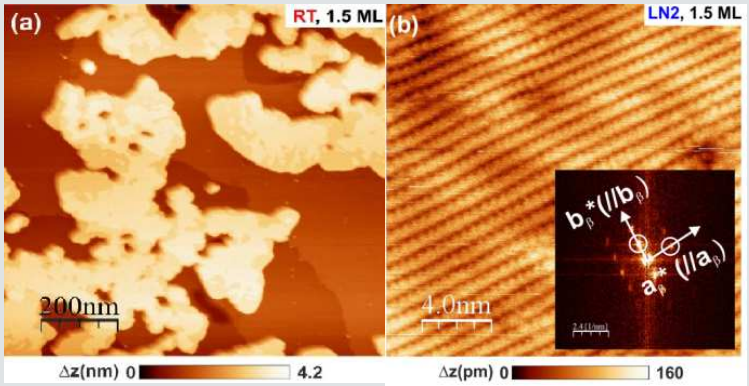
Intuiter correctement le n(λ) d'input du fit:
- *Dépendance en énergie*
- *Partie réelle et imaginaire*
- *Nombre de pics et écartement*
- *Rapport d'intensité des pics*

Caractérisation exhaustive du dépôt:
- *Épaisseur, homogénéité*
- *Rugosité*
- *Nombre de couches*
- *Orientation cristallographique*

Etude préalable de la DO(λ)

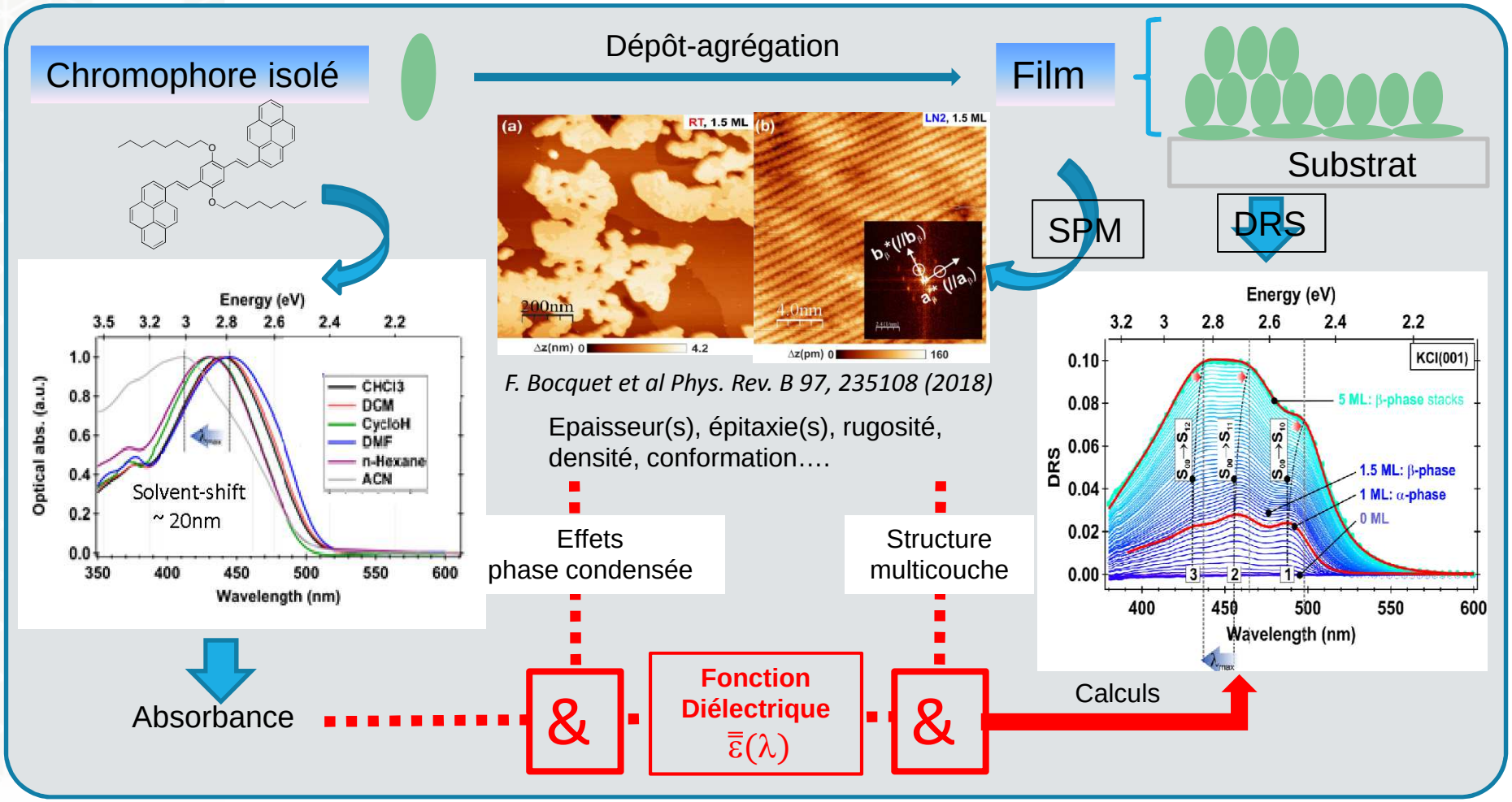


Analyse SPM « poussée »



Reminder, context of DRS

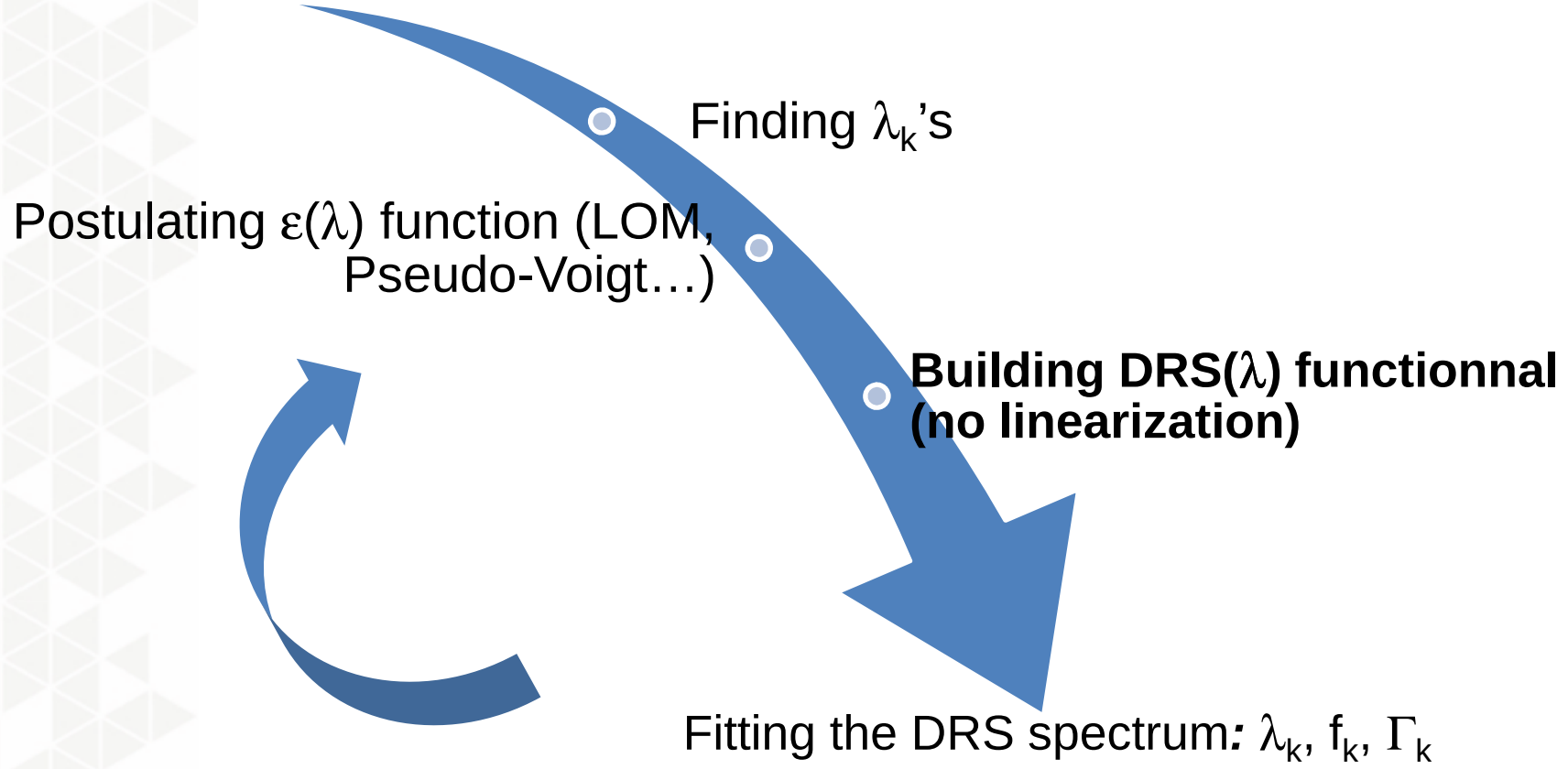
- Franck Bocquet's lecture on « Theoretical aspects of DRS on molecular films »:



Reminder, context of DRS

- Ultimate methodology to extract the dielectric function :

DRS spectrum



Outline

I. Reminder, context of DRS on molecular films

II. Tutorial video: experimental aspects of DRS on molecular films

III. Connection to the structural properties of the molecular films by nc-AFM

IV. DRS functionnal for fitting the DR spectra

V. Conclusion

List of publications

Tutorial video: experimental aspects of DRS

- **Part 1:** UHV setup for DRS and non-contact AFM
- **Part 2:** Preparing and introducing molecules
- **Part 3:** Preparing and introducing samples
- **Part 4:** Calibrating the molecular flux
- **Part 5:** Annealing the sample
- **Part 6:** DRS setup
- **Part 7:** Checking the optical alignment and the stability of the detection
- **Part 8:** DRS acquisition
- **Part 9:** Post-processing
- **Part 10:** Data analysis…

Tutorial video: experimental aspects of DRS

- **The link to the video:**

https://amubox.univ-amu.fr/s/4YRR2StjtGoaPGm

Outline

I. Reminder, context of DRS on molecular films

II. Tutorial video: experimental aspects of DRS on molecular films

III. Connection to the structural properties of the molecular films by nc-AFM

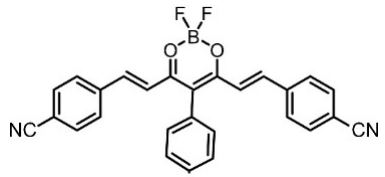
IV. DRS functionnal for fitting the DR spectra

V. Conclusion

List of publications

Connection to the structural properties of the molecular films by nc-AFM

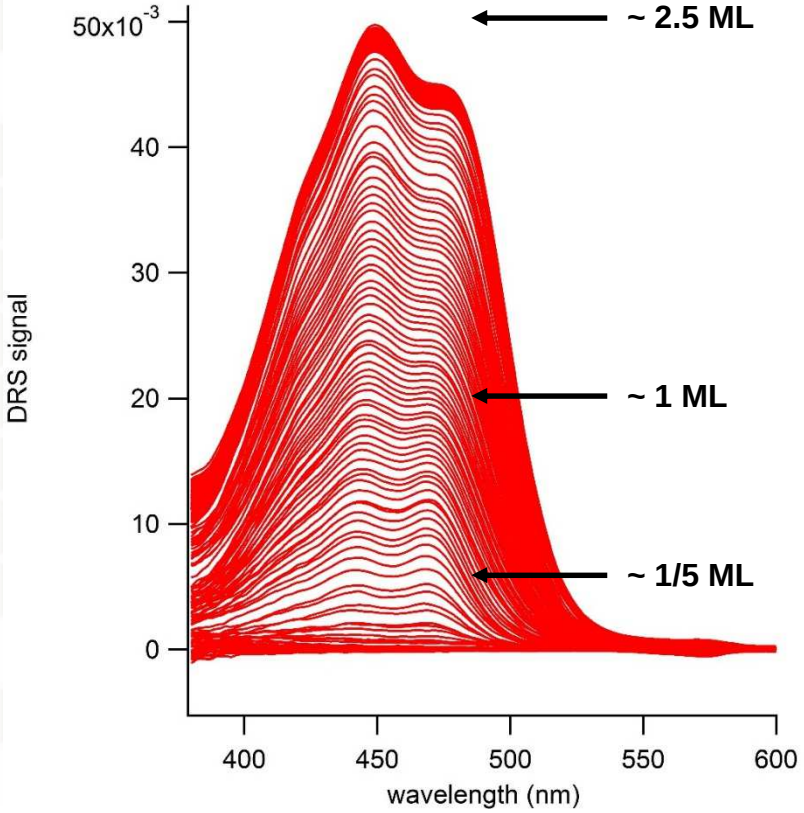
- Examplary case : curcuminoid chromophores

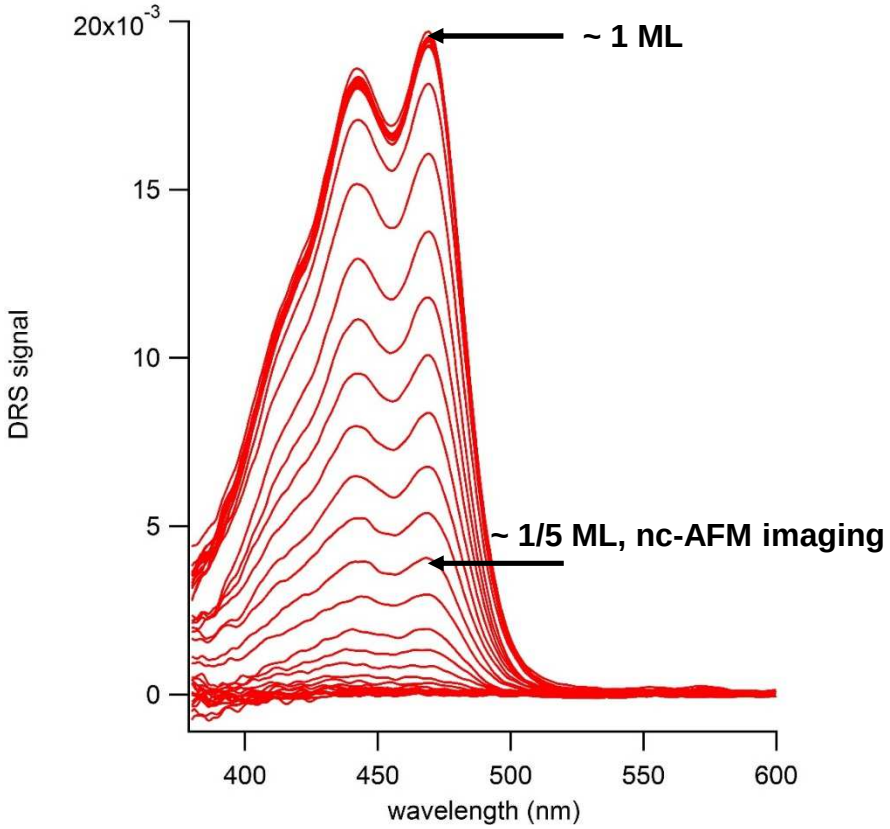


I: DRS in the multi-layer regime

III: DRS in the sub-ML regime

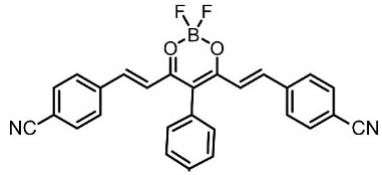
0.85A, rate: 0.07 Hz/min
~30 min acquisition, **~ 2.5 ML**



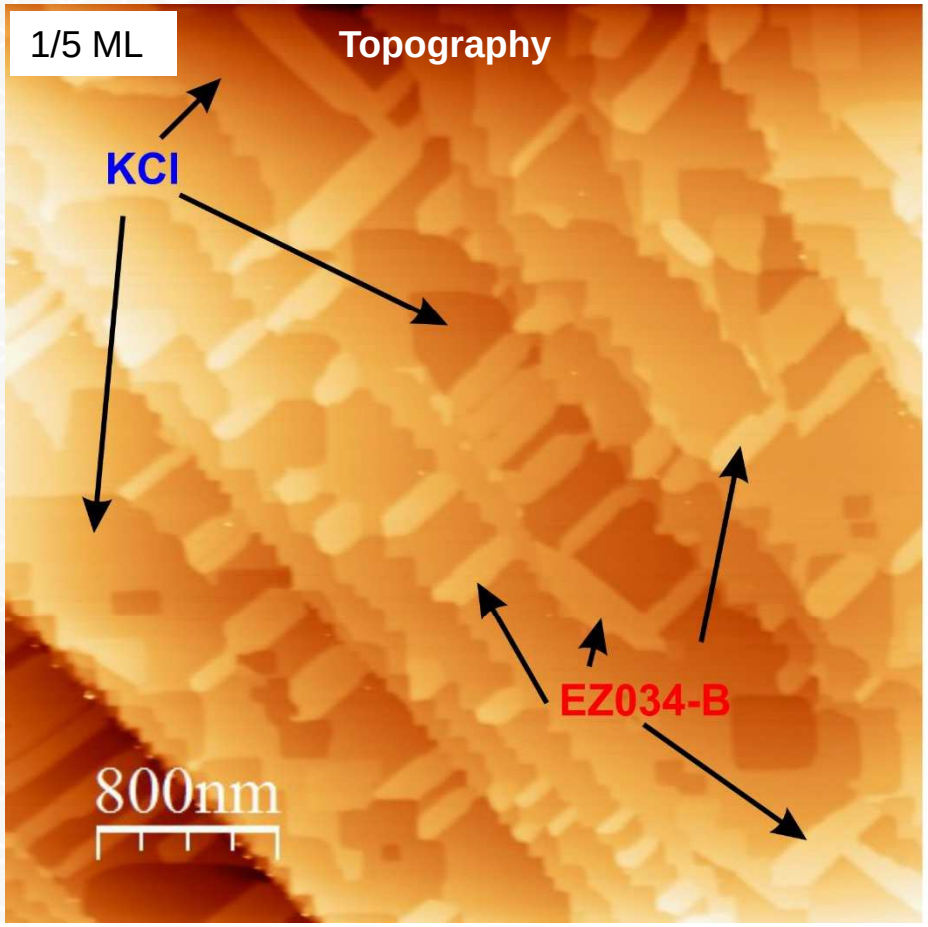


Connection to the structural properties of the molecular films by nc-AFM

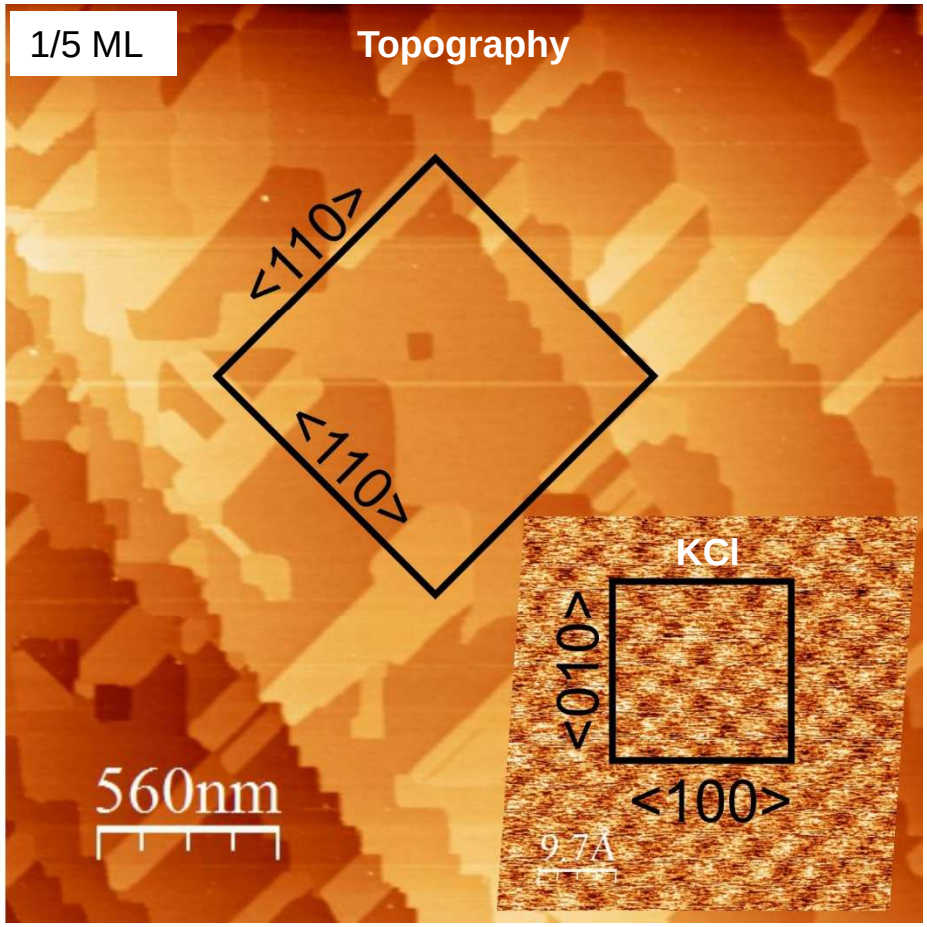
- Examplary case : curcuminoid chromophores



Large crystallites of equivalent domains

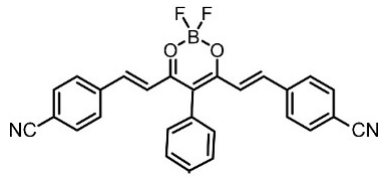


Orientations of ML @ +/-45°w.r.t. <100> direction



Connection to the structural properties of the molecular films by nc-AFM

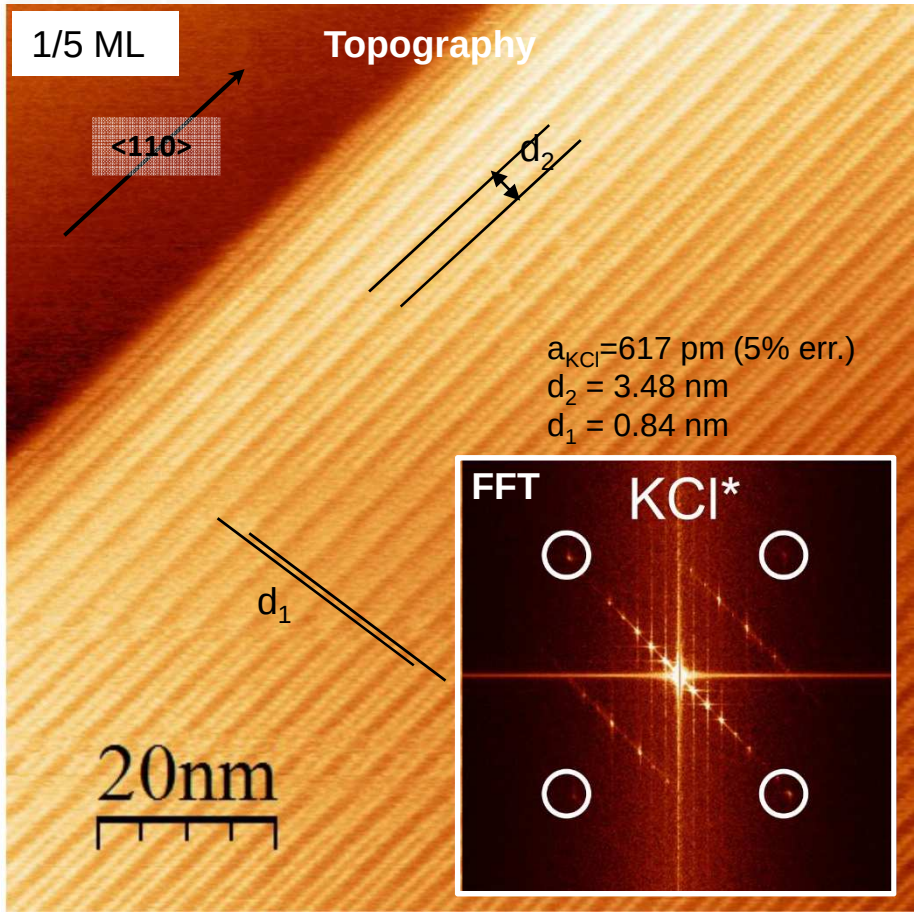
- Examplary case : curcuminoid chromophores

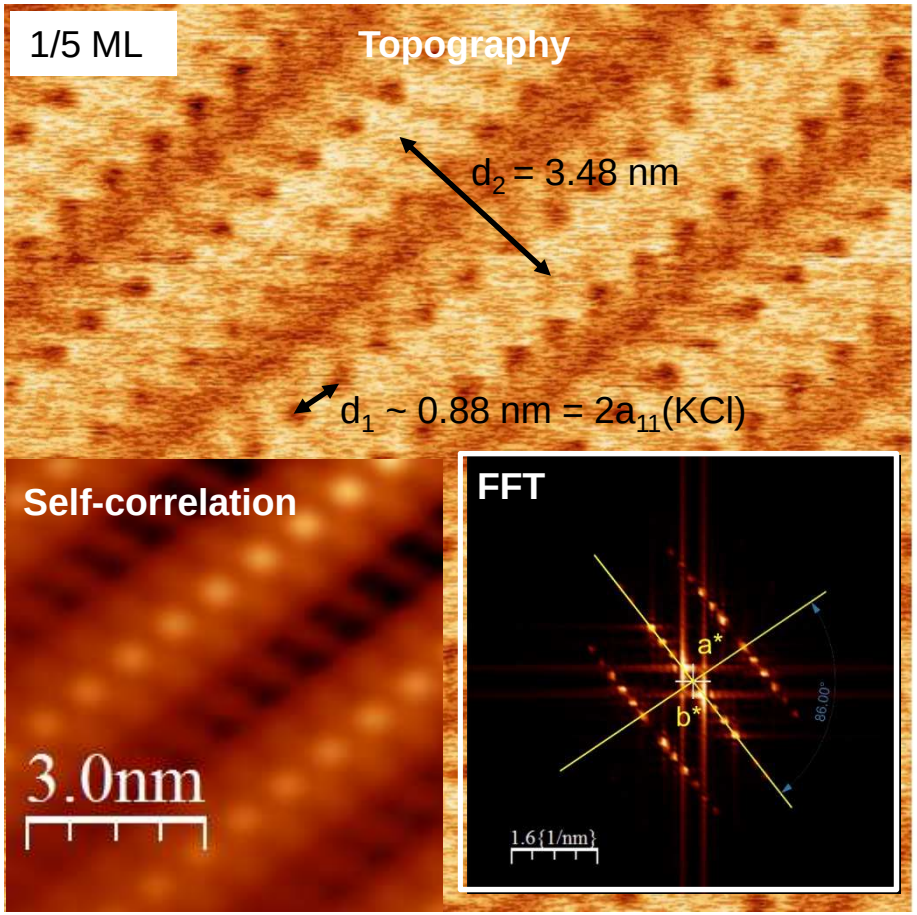


Zoom on a domain:

- Molecular rows match substrate's <110> polar lines
- Apparent height : 4.0 Å
- Atomic resolution on KCl (traces in FFT)

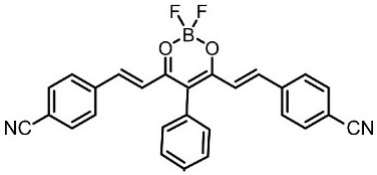
High-resolution imaging

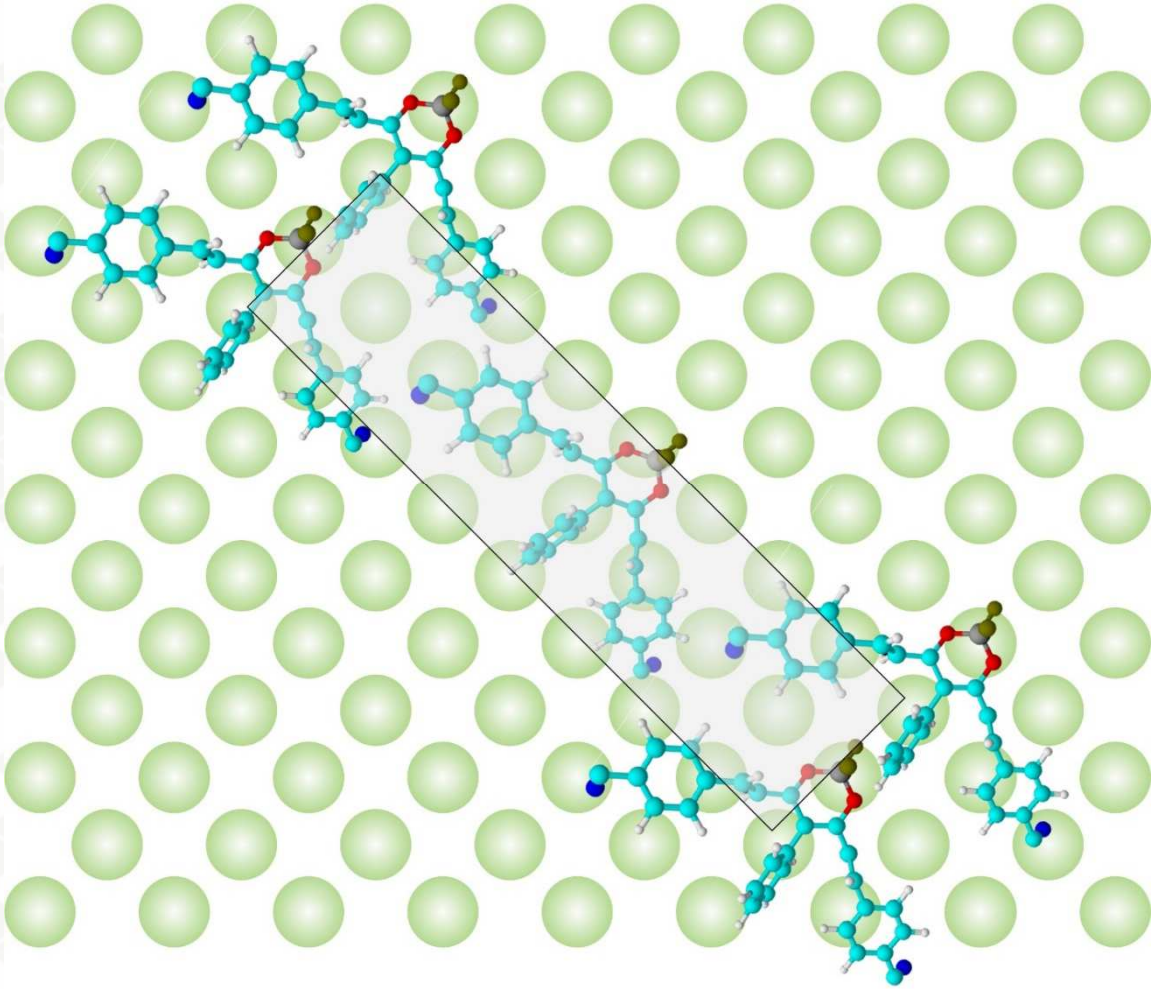




Connection to the structural properties of the molecular films by nc-AFM

- Examplary case : curcuminoid chromophores





- Epitaxy
- Density
- Molecular conformation
- Dipole transition orientation
- …

Inputs for the $\varepsilon(\lambda)$ function

Outline

I. Reminder, context of DRS on molecular films

II. Tutorial video: experimental aspects of DRS on molecular films

III. Connection to the structural properties of the molecular films by nc-AFM

IV. DRS functionnal for fitting the DR spectra

V. Conclusion

List of publications

DRS functionnal for fitting the DR spectra

- Beyond Mc Intyre's approach...
  - Back to optics basics…

$$\mathrm{DRS} = \frac{R(d_1) - R(0)}{R(0)} = \frac{|\,\widetilde{r}(d_1)\,|^2 - |\,\widetilde{r}(0)\,|^2}{|\,\widetilde{r}(0)\,|^2} \qquad \text{(Equ.0)}$$

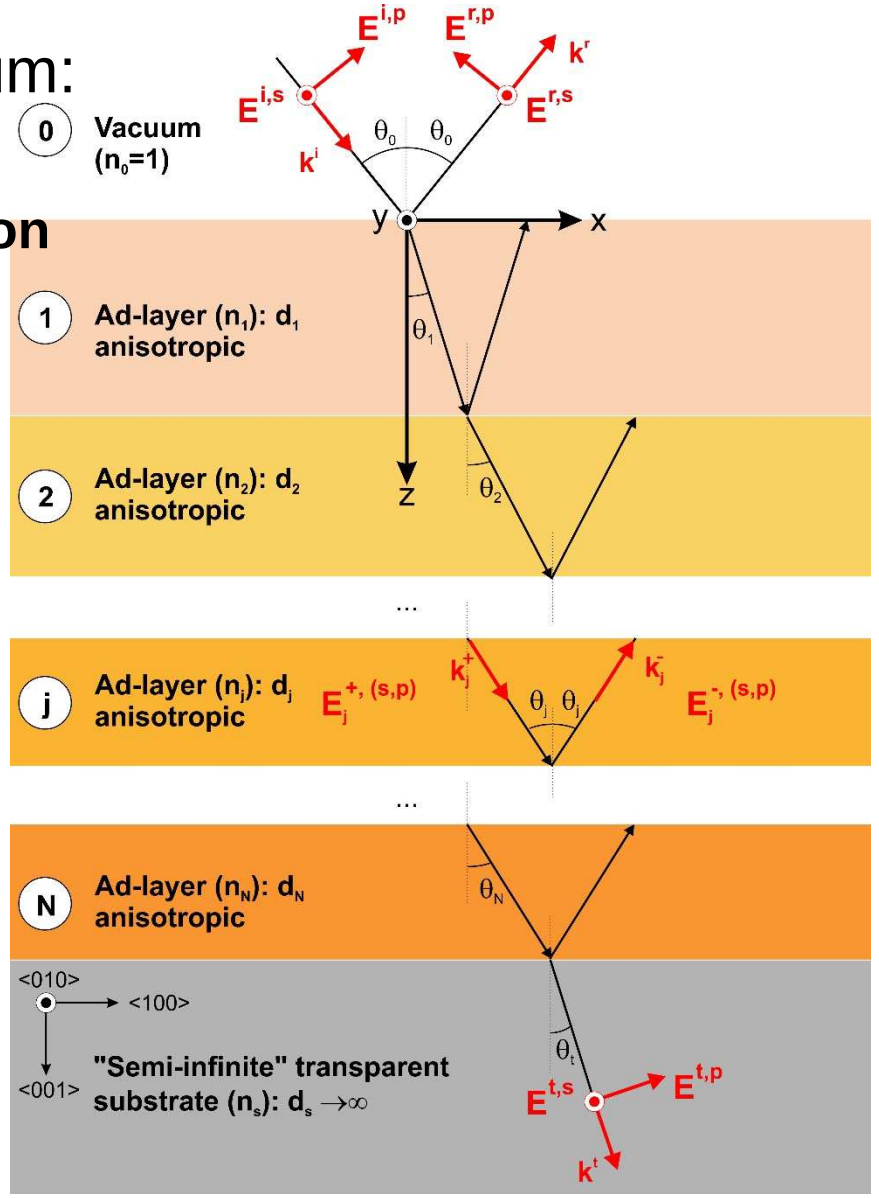
DRS functionnal for fitting the DR spectra

- Multi-layers = Stratified medium:
  - **Uniaxial material approximation**

    (x,y,z geom. accordingly with cristallographic axes)
    - z axis = optic axis
  - Dielectric tensor of the j[th] layer:

(Equ.1)
$$\overline{\overline{\epsilon}}_j = \begin{pmatrix} \tilde{\epsilon}_j^{\perp}(\lambda) & 0 & 0 \\ 0 & \tilde{\epsilon}_j^{\perp}(\lambda) & 0 \\ 0 & 0 & \tilde{\epsilon}_j^{\parallel}(\lambda) \end{pmatrix}$$

Hence, $\overline{\overline{n}}_j = \Re\{\overline{\overline{n}}_j\} + i\Im\{\overline{\overline{n}}_j\} = \sqrt{\overline{\overline{\epsilon}}_j}$



DRS functionnal for fitting the DR spectra

- Multi-layers = Stratified medium:
  - Electric field may be split into **s** (y axis) and **p** (x,z axes) polarizations:

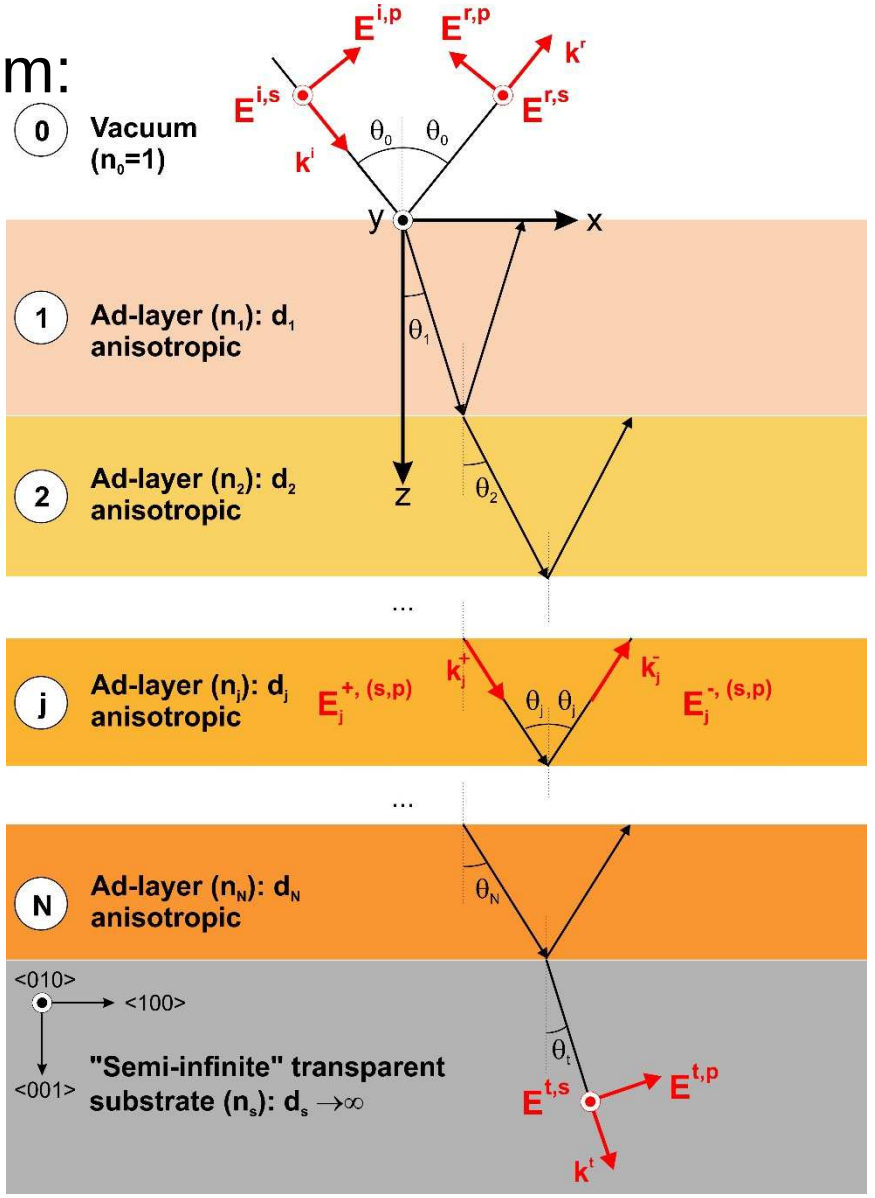
$$\mathbf{E}^{\dagger} = \mathbf{E}^{\dagger,s} + \mathbf{E}^{\dagger,p},$$

$$(\text{with } \dagger = i,\ r,\ \text{or } t)$$

  - Thus:

$$\begin{cases} \mathbf{E}^{\dagger,s} = E^{\dagger,y}\mathbf{e}_y e^{i[\omega t - k^{\dagger,x}x - k^{\dagger,z}z]} \\ \mathbf{E}^{\dagger,p} = \{E^{\dagger,x}\mathbf{e}_x + E^{\dagger,z}\mathbf{e}_z\} e^{i[\omega t - k^{\dagger,x}x - k^{\dagger,z}z]} \end{cases}$$

$$\text{with } \mathbf{k}^{\dagger} = k^{\dagger,x}\mathbf{e}_x + k^{\dagger,y}\mathbf{e}_y + k^{\dagger,z}\mathbf{e}_z$$



DRS functionnal for fitting the DR spectra

- Multi-layers = Stratified medium:
  - Reflection coefficient:

$$r^{(s,p)}(d) = \frac{\| \mathbf{E}^{r,(s,p)}(d) \|}{\| \mathbf{E}^{i,(s,p)} \|}$$

  - Reflectance components:

$$R^{(s,p)}(d) = |r^{(s,p)}(d)|^2$$

  - DRS components:

$$\mathrm{DRS}^{(s,p)}(d) = \frac{R^{(s,p)}(d) - R^{(s,p)}(0)}{R^{(s,p)}(0)}$$

  - Unpolarized DRS (***physical observable!***): $R^u(d) = [R^s(d) + R^p(d)]/2$

$$\mathrm{DRS}^u(d) = \frac{R^u(d) - R^u(0)}{R^u(0)} \quad \text{(Equ.2)}$$

DRS functionnal for fitting the DR spectra

- Transfer matrix method (TMM)[1]:
  - Wave vector for a jth layer

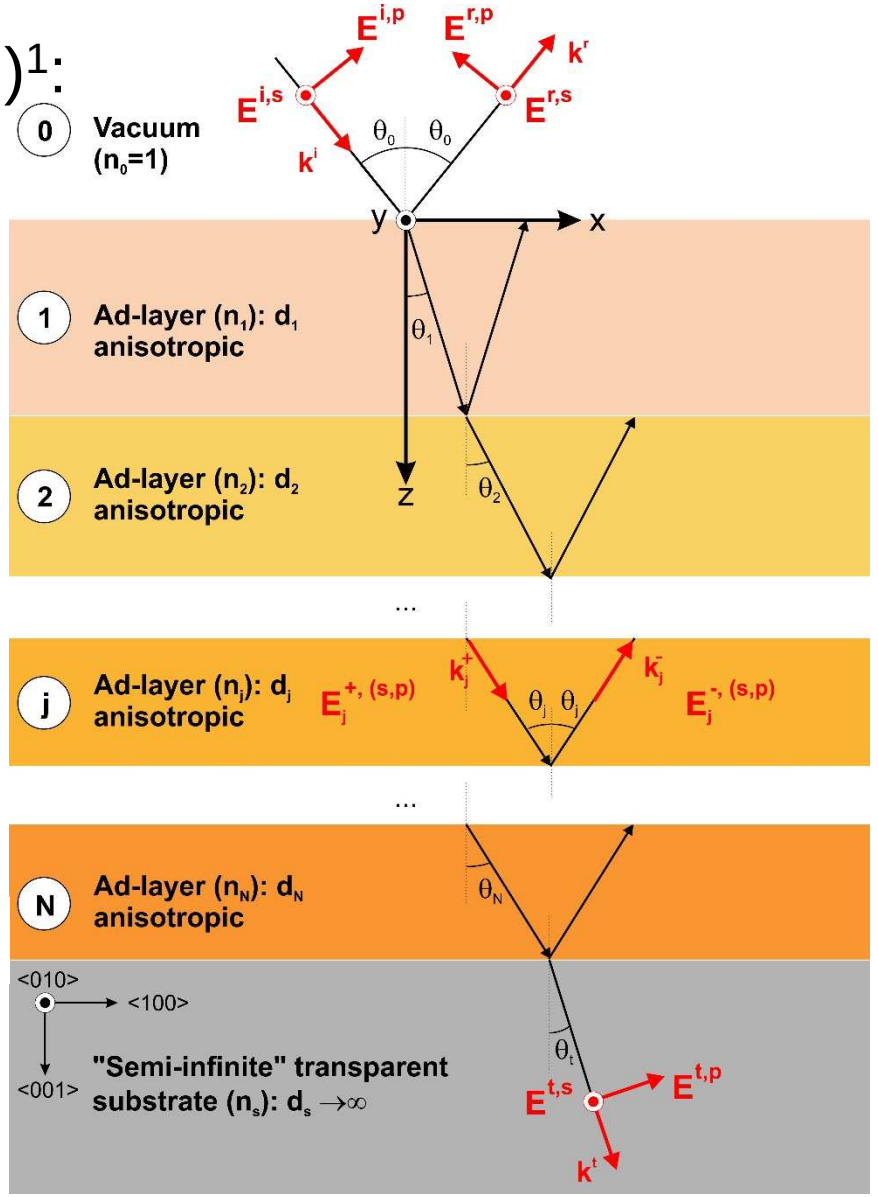
$$\mathbf{k}_j^{(i,r)} = k_j^{(i,r),x}\mathbf{e}_x + k_j^{(+,-),z}\mathbf{e}_z$$

with (Snell's laws):

$$\begin{cases} k_j^{(i,r),x} = \dfrac{2\pi}{\lambda} n_0 \sin(\theta_0) \\ k_j^{(+,-),z} = \pm\dfrac{2\pi}{\lambda}\tilde{n}_j(\lambda)\cos(\theta_j) \end{cases}$$

For instance:

$$\mathbf{E}^{(+,-),s} = E^{(+,-),y}\mathbf{e}_y e^{i[\omega t - k^{(+,-),x}x - k^{(+,-),z}z]}$$



[1]R. Azzam and N. Bashara, Ellipsometry and Polarized Ligth (North Holland, Amsterdam, 1977).

DRS functionnal for fitting the DR spectra

- Transfer matrix method (TMM)[1]:
  - Boundary conditions (Maxwell equs.) at each interface yield in-plane components of **s** and **p** polarizations:

$$\begin{pmatrix} E^{i,(x,y)} \\ E^{r,(x,y)} \end{pmatrix} = \frac{1}{2} \prod_{j=1}^{N} T_j \begin{pmatrix} \left[1 + \frac{\alpha_s}{\alpha_N}\right] E^{t,(x,y)} \\ \left[1 - \frac{\alpha_s}{\alpha_N}\right] E^{t,(x,y)} \end{pmatrix}$$

with the transfer matrix:

$$T_j = \frac{1}{2} \begin{pmatrix} \left[1 + \frac{\alpha_j}{\alpha_{(j-1)}}\right] e^{i\beta_j} & \left[1 - \frac{\alpha_j}{\alpha_{(j-1)}}\right] e^{-i\beta_j} \\ \left[1 - \frac{\alpha_j}{\alpha_{(j-1)}}\right] e^{i\beta_j} & \left[1 + \frac{\alpha_j}{\alpha_{(j-1)}}\right] e^{-i\beta_j} \end{pmatrix}$$

Hence (removal of the transmitted component):

$$r^{(x,y)}(d) = \frac{|E^{r,(x,y)}(d)|}{|E^{i,(x,y)}|} \qquad \text{(Equ.3)}$$

p polarization

s polarization

[1]R. Azzam and N. Bashara, Ellipsometry and Polarized Ligth (North Holland, Amsterdam, 1977).

DRS functionnal for fitting the DR spectra

- Transfer matrix method (TMM):
  - α_j and β_j coefficients:

    - ***s polarization case:*** $\mathbf{E}^{(+,-),s} = E^{(+,-),y}\mathbf{e}_y$ (phase omitted)

    Perpendicular to the optic axis = *ordinary direction*

$$\begin{cases} \alpha_j = \alpha_j^o = \tilde{n}_j^{\perp}\cos(\theta_j^o) \overbrace{=}^{\text{Snell-Descartes}} \sqrt{\tilde{n}_j^{\perp 2} - n_0^2\sin^2(\theta_0)} \\ \beta_j = \beta_j^o = \dfrac{2\pi d_j}{\lambda}\alpha_j^o. \end{cases} \quad \text{(Equ.4)}$$

    - ***p polarization case:*** $\mathbf{E}^{(+,-),p} = E^{(+,-),x}\mathbf{e}_x + E^{(+,-),z}\mathbf{e}_z$ (phase omitted)

    Parallel to the optic axis = *extraordinary direction*

$$\begin{cases} \alpha_j^e = \dfrac{\tilde{n}_j^{\perp}\tilde{n}_j^{\parallel}}{\sqrt{\tilde{n}_j^{\parallel 2} - n_0^2\sin^2(\theta_0)}} \\ \beta_j^e = \dfrac{2\pi d_j}{\lambda}\dfrac{\tilde{n}_j^{\perp}}{\alpha_j^e}. \end{cases} \quad \text{(Equ.5)}$$

DRS functionnal for fitting the DR spectra

- Summary: the combination between…

$$\begin{cases} \alpha_j = \alpha_j^o = \tilde{n}_j^{\perp} \cos(\theta_j^o) \\ \beta_j = \beta_j^o = \dfrac{2\pi d_j}{\lambda} \alpha_j^o . \end{cases} \overbrace{=}^{\text{Snell-Descartes}} \sqrt{\tilde{n}_j^{\perp 2} - n_0^2 \sin^2(\theta_0)} \quad \& \quad \begin{cases} \alpha_j^e = \dfrac{\tilde{n}_j^{\perp} \tilde{n}_j^{\parallel}}{\sqrt{\tilde{n}_j^{\parallel 2} - n_0^2 \sin^2(\theta_0)}} \\ \beta_j^e = \dfrac{2\pi d_j}{\lambda} \dfrac{\tilde{n}_j^{\perp}}{\alpha_j^e} . \end{cases}$$

(Equ.4) (Equ.5)

(Equ.3) $$r^{(x,y)}(d) = \frac{|E^{r,(x,y)}(d)|}{|E^{i,(x,y)}|}$$

(Equ.1) $$\overline{\overline{\epsilon}}_j = \begin{pmatrix} \tilde{\epsilon}_j^{\perp}(\lambda) & 0 & 0 \\ 0 & \tilde{\epsilon}_j^{\perp}(\lambda) & 0 \\ 0 & 0 & \tilde{\epsilon}_j^{\parallel}(\lambda) \end{pmatrix}$$

And (Equ.2): $$\mathrm{DRS}^u(d) = \frac{R^u(d) - R^u(0)}{R^u(0)}$$ yields the DRS **fitting functionnal!**

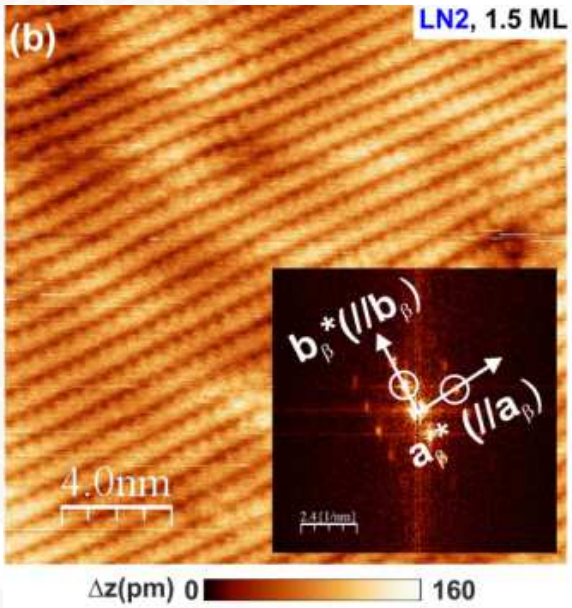
DRS functionnal for fitting the DR spectra

- But ε(λ) is still to be known as an input of the DRS functionnal…

  – In case of a **homogeneous layer**: Lorentz Oscillator Model (cf. Franck Bocquet's lecture):

Number of transitions

$$\tilde{\epsilon}_{\mathrm{LOM}}(\lambda) = \epsilon^{\infty} + \sum_{j=1}^{3} \frac{f_j}{1 - \left(\frac{\lambda_j}{\lambda}\right)^2 + i\gamma_j\left(\frac{\lambda_j}{\lambda}\right)}$$

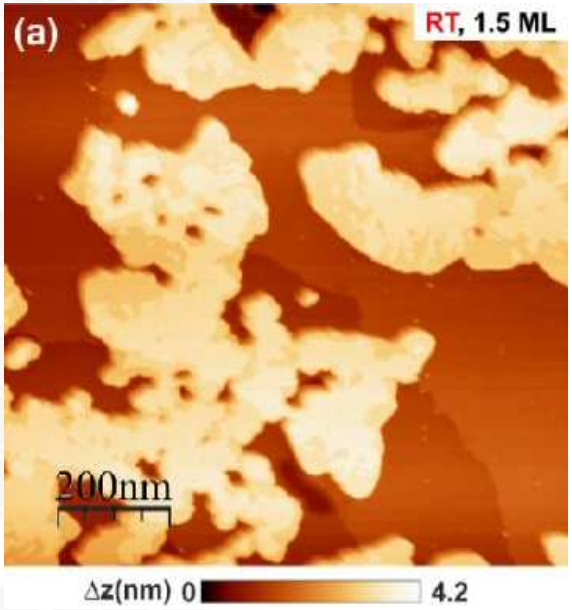


With:

- f_j = oscillator strength
- λ_j = absorption wavelength
- γ_j = peak width (relates to state lifetime)

DRS functionnal for fitting the DR spectra

- But ε(λ) is still to be known as an input of the DRS functionnal…
  - In case of an **inhomogeneous layer**: Effective Medium Theory[1] + Lorentz Oscillator Model:



$$\epsilon_{\mathrm{EMT}}^{\perp,\parallel}(\lambda) = \epsilon_h(\lambda)\frac{\epsilon_h(\lambda) + [\nu(1-f)+f][\epsilon^{\perp,\parallel}(\lambda) - \epsilon_h(\lambda)]}{\epsilon_h(\lambda) + \nu(1-f)[\epsilon^{\perp,\parallel}(\lambda) - \epsilon_h(\lambda)]}$$

Dielectric function of the hosting material: vacuum

Form factor

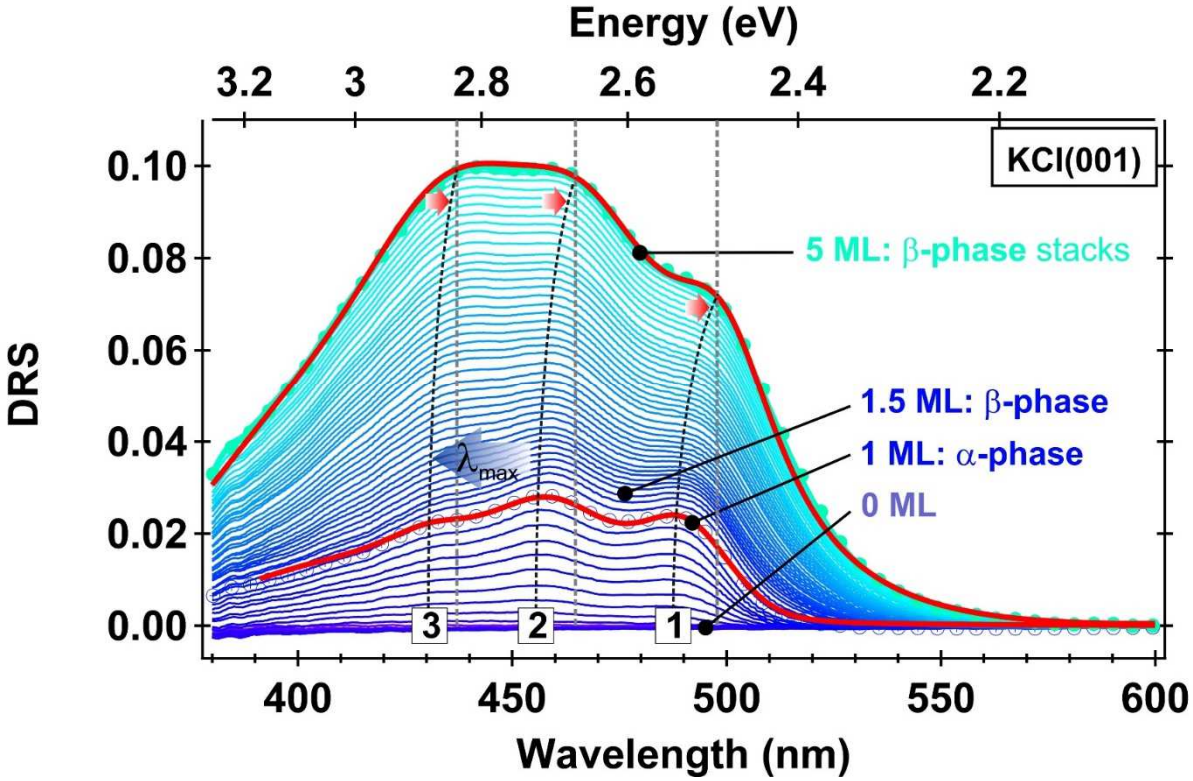
Filling parameter [0;1]

$$\tilde{\epsilon}_{\mathrm{LOM}}(\lambda) = \epsilon^{\infty} + \sum_{j=1}^{3} \frac{f_j}{1 - \left(\frac{\lambda_j}{\lambda}\right)^2 + i\gamma_j\left(\frac{\lambda_j}{\lambda}\right)}$$

[1]B. J. C. Maxwell Garnet, Philos. Trans. R. Soc., A **203**, 385 (1904); V. Markel, J. Opt. Soc. Am. A **33**, 1244 (1916).

DRS functionnal for fitting the DR spectra

- The fits (Levenberg-Marquardt algorithm) are then performed on the experimental DR spectra with a Mathematica program and allow for the extraction of the dielectric function of the molecular layer, as well as an estimate of its thickness…



Outline

I. Reminder, context of DRS on molecular films

II. Tutorial video: experimental aspects of DRS on molecular films

III. Connection to the structural properties of the molecular films by nc-AFM

IV. DRS functionnal for fitting the DR spectra

V. Conclusion

List of publications

Conclusion

I. DRS on organic layers in UHV is an actual spectroscopic method to measure the UV-vis absorption spectrum of the organic layers

II. Its experimental implementation is fairly simple

III. Upon stability achievment, the method is sensitive to a fraction of ML

IV. The quantitative extraction of the dielectric function of the molecular layers is tedious and rely on many approaches (stratified medium, uniaxial material, LOM, EMT…), whose relevance is to be estimated at best, and based on the molecular structure of the layers, the optical density of the molecules in solution…

V. The interpretation of DR spectra without further information is useless : this can only be performed in connection with other inputs originating from other characterization methods

Acknowledgments

Institut Matériaux Microélectronique Nanosciences de Provence

Nanostructuration group members @ IM2NP:

- Christian Loppacher
- Franck Bocquet
- Franck Para
- Sylvain Clair
- Luca Giovanelli
- Younal Ksari
- Jean-Marc Themlin

CINaM

Colleagues @ CINaM:

- Thomas Léoni
- Conrad Becker
- Laurence Masson
- Romain Parret
- Frédéric Fagès
- Elena Zaborova

Institut Matériaux Microélectronique Nanosciences Provence

Merci pour votre attention

Relier le fondamental aux applications dans nos domaines d'expertise

www.im2np.fr

List of publications of the « non-contact AFM » team (2008)

- *« Analytical approach to the local contact potential difference on (100) ionic surfaces: implications for KPFM »,* F.Bocquet, L.Nony, Ch.Loppacher and Th.Glatzel, **Phys. Rev. B** 78, 035410 (2008).
- *« Evolution of the Electronic Structure at the Interface between a Thin Film of Halogenated Phthalocyanine and the Ag(111) Surface »,* L.Giovanelli, P.Amsalem, J.M.Themlin, Y.Ksari, M.Abel, L.Nony, M.Koudia, F.Bondino, E.Magnano, M.Mossoyan-Deneux, and L.Porte, **J. Phys. Chem. C** 112, 8654-8661 (2008).
- *« Interface dipole formation of different ZnPcCl8 phases on Ag(111) observed by Kelvin probe force microscopy »,* P.Milde, U.Zerweck, L.Eng, M.Abel, L.Giovanelli, L.Nony, M.Mossoyan, L.Porte, and Ch.Loppacher, **Nanotechnology** 19, 305501 (2008).
- *« On the relevance of the atomic-scale contact potential difference by amplitude modulation- and frequency modulation-Kelvin probe force microscopy », L.*Nony, F.Bocquet, Ch.Loppacher and Th.Glatzel, **Nanotechnology** 20, 264014 (2009).
- *« Robust supramolecular network on Ag(111): hydrogen-bond enhancement through partial alcohol dehydrogenation »,* R.Pawlak, S.Clair, V.Oison, M.Abel, O.Ourdjini, N.A.A.Zwaneveld, D.Gigmes, D.Bertin, L.Nony and L.Porte, **ChemPhysChem** 10, 1032-1035 (2009).
- *« Understanding the Atomic-Scale Contrast in Kelvin Probe Force Microscopy »,* L.Nony, A.S.Foster, F.Bocquet and Ch.Loppacher, **Phys. Rev. Lett.** 103, 036802 (2009).
- *« Supramolecular Assemblies of 1,4-Benzene Diboronic Acid on KCl(001) »,* R.Pawlak, L.Nony, F.Bocquet, V.Oison, M.Sassi, J.-M.Debierre, Ch.Loppacher, and L.Porte, **J. Phys. Chem. C** 114, 9290–9295 (2010).
- *« Polarization effects in noncontact atomic force microscopy: A key to model the tip-sample interaction above charged adatoms »,* F.Bocquet, L.Nony, and Ch.Loppacher, **Phys. Rev. B** 83, 035411 (2011).
- *« Contribution of the numerical approach to Kelvin Probe Force Microscopy on the atomic-scale »,* L.Nony, A.S.Foster, F.Bocquet and Ch.Loppacher. Chapter in the book *«Kelvin Probe Force Microscopy»*, (Eds. Sascha Sadewasser & Thilo Glatzel), **Springer-Verlag Berlin Heidelberg** (2011) (DOI 10.1007/978-3-642-22566-6)

List of publications of the « non-contact AFM » team (2008)

- *«FPGA-based programmable digital PLL with very high frequency resolution»*, J.Bouloc, L.Nony, C.Loppacher, W.Rahajandraibe, F.Bocquet, L.Zaid, **Electronics, Circuits and Systems(ICECS), 2011 18th IEEE International Conference on**, 2011, Page(s): 370 – 373.
- *« Self-organized growth of molecular arrays at surfaces »,* L.Porte *et al.*, **Int. J. Nanotechnology** 9(3,4,5,6,7), p325-354 (2012).
- *« Graphite, graphene on SiC,and graphene nanoribbons: Calculated images with a numerical FM-AFM »,* F.Castanié, L.Nony, S.Gauthier and X.Bouju, **Beilstein J. of Nanotechnology** 3, p301-311 (2012).
- *« Dipole-driven self-organization of zwitterionic molecules on alkali halide surfaces »,* L.Nony et al., **Beilstein J. of Nanotechnology** 3, p285-293 (2012).
- *« Inhomogeneous relaxation of a molecular layer on an insulator due to compressive stress »,* F.Bocquet, L.Nony, S.C.B.Mannsfeld, V.Oison, R.Pawlak, L.Porte and Ch.Loppacher, **Phys. Rev. Lett.** 108, 206103 (2012).
- *« Image Calculations with a Numerical Frequency-Modulation Atomic Force Microscope »,* F.Castanié, L.Nony, S.Gauthier, and X.Bouju, **J. Phys. Chem. C** 117, 10492 (2013).
- *« Correct height measurements by Kelvin probe force microscopy: Poly(3-dodecylthiophene) on highly oriented pyrolytic graphite »,* F.Fuchs, B.Grévin, F.Bocquet, L.Nony, and Ch.Loppacher, **Phys. Rev. B** 88, 205423 (2013).
- *« Electrothermally driven high-frequency piezoresistive SiC cantilevers for dynamic atomic force microscopy »,* R.Boubekri, E.Cambril, L.Couraud, L.Bernardi, A.Madouri, M.Portail, T.Chassagne, C.Moisson, M.Zielinski, S.Jiao, J.-F.Michaud, D.Alquier, J.Bouloc, L.Nony, F.Bocquet, Ch.Loppacher, D.Martrou, and S.Gauthier, **J. Appl. Phys.** 116, 054304 (2014).

List of publications of the « non-contact AFM » team (2008)

- *«Molecular design and control over the morphology of self-assembled films on ionic substrates»,* A.Amrous, F.Bocquet, L.Nony, F.Para, Ch.Loppacher, S.Lamare, F.Palmino, F.Chérioux, D.Z.Gao, F.F.Canova, M.B.Watkins and A.L.Shluger, **Adv. Mat. Interf.** 1**,** 1400414 (2014).
- *« Supramolecular networks on a silicon surface or on insulators»,* M.Beyer, Y.Makoudi, S.Lamarre, J.Jeannoutot, F.Palmino, F.Chérioux, A.Amrous, F.Bocquet, L.Nony, F.Para and Ch.Loppacher, **Abstracts of papers of the American Chemical Society**, 247, 342-COLL (2014).
- *« Integration of the RHK R9 to an Omicron VT-AFM »,* L.Nony, F.Para, F.Bocquet and Ch.Loppacher, http://www.rhk-tech.com/wp-content/uploads/2016/02/R9_Omicron_ApplicationNote.pdf, RHK Technology Application Note (2015).
- *« Frequency shift, damping and tunneling current coupling with quartz tuning forks in non-contact atomic force microscopy »,* L.Nony, F.Bocquet, F.Para and Ch.Loppacher, **Phys.Rev.B.** 94, 115421 (2016).
- *« Morphology and growth mechanisms of self-assembled films on insulating substrates: role of molecular flexibility and entropy»,* J.Gaberle, D.Z. Gao, A.L. Shluger, S.Lamare, F.Palmino, F.Cherioux, A.Amrous, F.Bocquet, L.Nony, F.Para, and Ch.Loppacher, **J. Phys. Chem C** 121, 4393-4401 (2017).
- *« Non-contact AFM and Differential Reflectance Spectroscopy joint analyzes of bispyrenyl thin films on bulk insulators: relationship between structural and optical properties»,* F.Bocquet, L.Nony, F.Para, P.Luangprasert, J.-V.Naubron, Ch.Loppacher, T.Leoni, A.Thomas, A.Ranguis, A.d'Aleo, F.Fages, and C.Becker, **Phys.Rev.B** 97, 235434 (2018).
- *« Micrometer-long covalent organic fibres by photo-initiated radical polymerisation on an alkali halide surface »,* F.Para, F.Bocquet, L.Nony, Ch.Loppacher, M.Feron, F.Cherioux, D.Z.Gao, M.Watkins, **Nature Chemistry** (2018)